

**Search Notes**

Application/Control No.

10/652,331

Examiner

Nhan T. Le

Applicant(s)/Patent under  
Reexamination

YEO ET AL.

Art Unit

2685

**SEARCHED**

Class	Subclass	Date	Examiner
455	131	01/13/06	N Le
	313	/	/
	324	/	/
	323	/	/
371	283		
	386		
375	340		
	346		
	3249	↓	↓

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Eastsearch	01/13/06	N, Le

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner